

Search Notes



Application/Control No.

10/783,763

Examiner

Kin-Chan Chen

Applicant(s)/Patent under
Reexamination

LEE, WHONCHEE

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	689	12/2/2005	KCC
438	693	12/2/05	KCC
451	287		
	288		
	443		
451	444		
205	662		
	670		
	671		
205	672	12/2/05	KCC
updated		8/21/06	KCC

INTERFERENCE SEARCHED

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438	689	8/21/06	KCC
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205	662		
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	671		
205	672	8/21/06	KCC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Keywords searched USPT, USPT- pub. Ep, JP, Derwent IBM TDB, inventor search	12/2/2005	KCC
updated	8/21/06	KCC